

Search Notes

Application/Control No.

10/073,636

Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

AVISON, BEN

Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner
725	87-90,102	9/11/2006	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR